Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/757,415	KANEKO ET AL.	
Examiner	Art Unit	
Ayal I. Sharon	2123	

	SEAR	CHED	
Class	Subclass	Date	Examiner
703	14	5/17/2007	cayol ayul
716	4, 11, 12	5/17/2007	ayel
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	J				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST, IEEE, Google See attached search notes	5/17/2007	aysl		
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